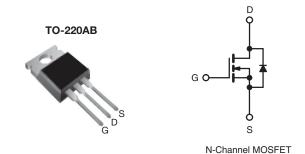


Power MOSFET

PRODUCT SUMMARY					
V _{DS} (V)	60				
$R_{DS(on)}(\Omega)$	V _{GS} = 5.0 V 0.028				
Q _g (Max.) (nC)	66				
Q _{gs} (nC)	12				
Q _{gd} (nC)	43				
Configuration	Single				



FEATURES

- Dynamic dV/dt Rating
- · Logic-Level Gate Drive
- R_{DS(on)} Specified at V_{GS} = 4 V and 5 V
- 175 °C Operating Temperature
- Fast Switching
- Ease of Paralleling
- Simple Drive Requirements
- Compliant to RoHS Directive 2002/95/EC

DESCRIPTION

Third generation Power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The TO-220AB package is universally preferred for all commercial-industrial applications at power dissipation levels to approximately 50 W. The low thermal resistance and low package cost of the TO-220AB contribute to its wide acceptance throughout the industry.

ORDERING INFORMATION	
Package	TO-220AB
Lead (Pb)-free	IRLZ44PbF
	SiHLZ44-E3
SnPb	IRLZ44
	SiHLZ44

ABSOLUTE MAXIMUM RATINGS (T_C :	= 25 °C, unl	ess otherwis	se noted)			
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V_{DS}	60		
Gate-Source Voltage			V_{GS}	± 10	V	
Continuous Drain Currente	\/ at F.O.\/	T _C = 25 °C	- I _D	50	А	
Continuous Drain Current	V _{GS} at 5.0 V	T _C = 100 °C		36		
Pulsed Drain Current ^a			I _{DM}	200		
Linear Derating Factor				1.0	W/°C	
Single Pulse Avalanche Energy ^b	E _{AS}	400	mJ			
Maximum Power Dissipation $T_C = 25 ^{\circ}\text{C}$			P _D	150	W	
Peak Diode Recovery dV/dtc	dV/dt	4.5	V/ns			
Operating Junction and Storage Temperature Range			T _J , T _{stg}	- 55 to + 175	- °C	
Soldering Recommendations (Peak Temperature) ^d	for 10 s			300		
Mounting Torque	6-32 or M3 screw			10	lbf ⋅ in	
Mounting Torque				1.1	N · m	

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. V_{DD} = 25 V, starting T_J = 25 °C, L = 179 μ H, R_g = 25 Ω , I_{AS} = 51 A (see fig. 12). c. $I_{SD} \le 51$ A, $dV/dt \le 250$ A/s, $V_{DD} \le V_{DS}$, $T_J \le 175$ °C.
- d. 1.6 mm from case.
- e. Current limited by the package, (die current = 51 A).

^{*} Pb containing terminations are not RoHS compliant, exemptions may apply



THERMAL RESISTANCE RATINGS						
PARAMETER	SYMBOL	TYP.	MAX.	UNIT		
Maximum Junction-to-Ambient	R _{thJA}	-	62			
Case-to-Sink, Flat, Greased Surface	R _{thCS}	0.50	-	°C/W		
Maximum Junction-to-Case (Drain)	R _{thJC}	-	1.0			

PARAMETER	SYMBOL	TEST (MIN.	TYP.	MAX.	UNIT		
Static		1					ı	
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		60	_	-	V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference t	o 25 °C, I _D = 1 mA	-	0.070	-	V/°C	
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{c}$	_{GS} , I _D = 250 μA	1.0	-	2.0	V	
Gate-Source Leakage	I _{GSS}	Vo	V _{GS} = 10 V		-	± 100	nA	
Zana Cata Valtana Busin Courset	I _{DSS}	$V_{DS} = 6$	V _{DS} = 60 V, V _{GS} = 0 V		-	25		
Zero Gate Voltage Drain Current		$V_{DS} = 48 \text{ V}, V_{0}$	_{GS} = 0 V, T _J = 150 °C	-	-	250	μA	
Duein Course On Otata Basistana	D	V _{GS} = 5.0 V	I _D = 31 A ^b	-	-	0.028		
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 4.0 V	I _D = 25 A ^b	-	-	0.039	Ω	
Forward Transconductance	9fs	V _{DS} = 2	5 V, I _D = 31 A ^b	23	-	-	S	
Dynamic								
Input Capacitance	C _{iss}	V	$V_{GS} = 0 V$,		3300	-		
Output Capacitance	C _{oss}	V _D	$_{0S} = 25 \text{ V},$	-	1200	-	pF	
Reverse Transfer Capacitance	C _{rss}	f = 1.0 MHz, see fig. 5		-	200	-	1	
Total Gate Charge	Q_g			-	-	66	nC	
Gate-Source Charge	Q _{gs}	V _{GS} = 5.0 V	$I_D = 51 \text{ A}, V_{DS} = 48 \text{ V},$ see fig. 6 and 13 ^b	=	-	12		
Gate-Drain Charge	Q_{gd}		See fig. 6 and 16		-	43]	
Turn-On Delay Time	t _{d(on)}	·		-	17	-	ns	
Rise Time	t _r	V _{DD} = 3	$V_{DD} = 30 \text{ V}, I_D = 51 \text{ A},$		230	-		
Turn-Off Delay Time	t _{d(off)}	$R_g = 4.6 \Omega$, $R_D = 0.56 \Omega$, see fig. 10^b		-	42	-		
Fall Time	t _f			=	110	-		
Internal Drain Inductance	L_D		Between lead, 6 mm (0.25") from		4.5	-	nЦ	
Internal Source Inductance	L _S	package and center of die contact		-	7.5	-	nH	
Drain-Source Body Diode Characteristic	s							
Continuous Source-Drain Diode Current	I _S	MOSFET symbol showing the integral reverse p - n junction diode		-	-	50°	Α	
Pulsed Diode Forward Current ^a	I _{SM}			-	-	200	7	
Body Diode Voltage	V_{SD}	T _J = 25 °C, I _S = 51 A, V _{GS} = 0 V ^b		-	-	2.5	V	
Body Diode Reverse Recovery Time	t _{rr}	- T _J = 25 °C, I _F = 51 A, dl/dt = 100 A/μs ^b		-	130	180	ns	
Body Diode Reverse Recovery Charge	Q _{rr}			-	0.84	1.3	μC	
Forward Turn-On Time	t _{on}	Intrinsic turn-	-on is do	minated b	y L _S and	LD)		

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Pulse width \leq 300 μ s; duty cycle \leq 2 %.
- c. Current limited by the package, (die current = 51 A).



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

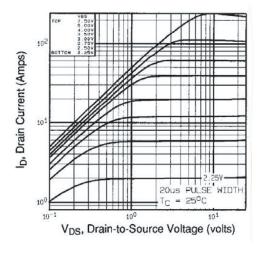


Fig. 1 - Typical Output Characteristics, T_C = 25 °C

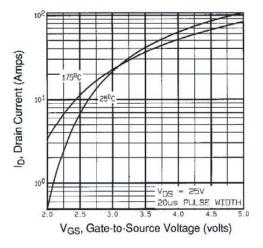


Fig. 3 - Typical Transfer Characteristics

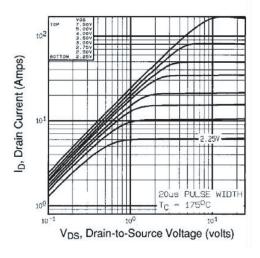


Fig. 2 - Typical Output Characteristics, T_C = 175 °C

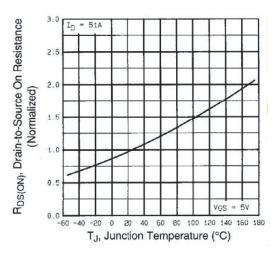


Fig. 4 - Normalized On-Resistance vs. Temperature



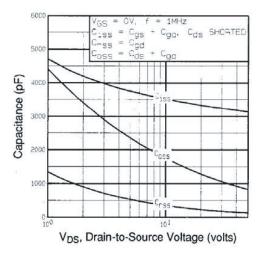


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

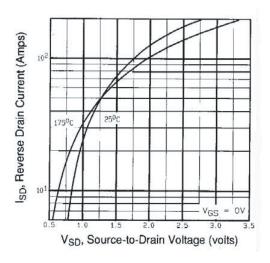


Fig. 7 - Typical Source-Drain Diode Forward Voltage

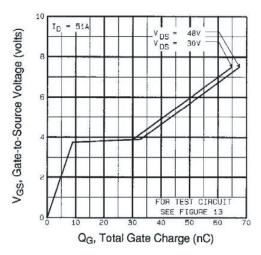


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

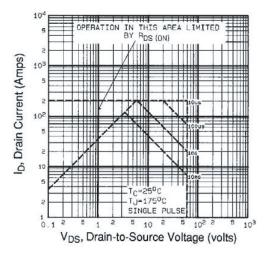


Fig. 8 - Maximum Safe Operating Area





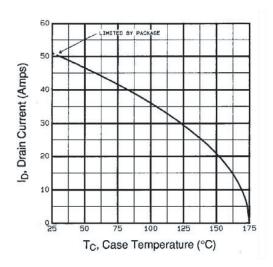


Fig. 9 - Maximum Drain Current vs. Case Temperature

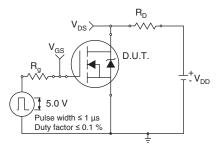


Fig. 10a - Switching Time Test Circuit

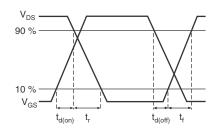


Fig. 10b - Switching Time Waveforms

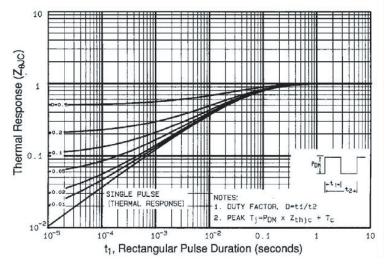
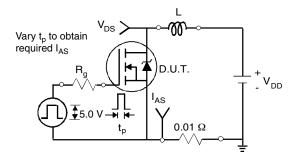


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case





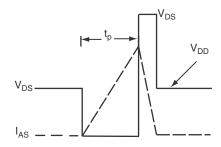


Fig. 12a - Unclamped Inductive Test Circuit

Fig. 12b - Unclamped Inductive Waveforms

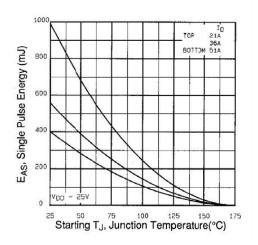


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

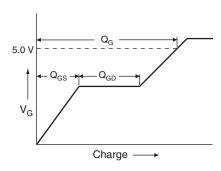


Fig. 13a - Basic Gate Charge Waveform

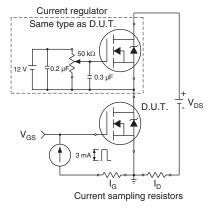
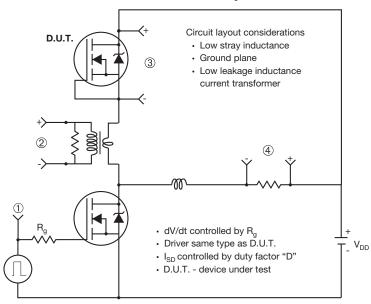


Fig. 13b - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit



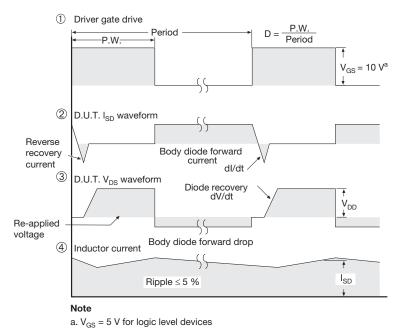


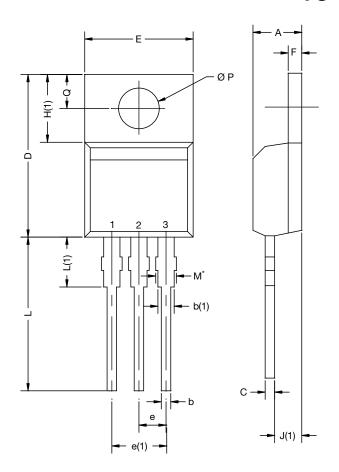
Fig. 14 - For N-Channel

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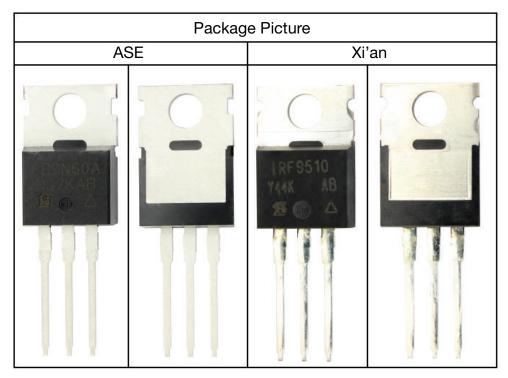
TO-220-1



DIM.	MILLIM	IETERS	INCHES			
DIM.	MIN.	MAX.	MIN.	MAX.		
Α	4.24	4.65	0.167	0.183		
b	0.69	1.02	0.027	0.040		
b(1)	1.14	1.78	0.045	0.070		
С	0.36	0.61	0.014	0.024		
D	14.33	15.85	0.564	0.624		
Е	9.96	10.52	0.392	0.414		
е	2.41	2.67	0.095	0.105		
e(1)	4.88	5.28	0.192	0.208		
F	1.14	1.40	0.045	0.055		
H(1)	6.10	6.71	0.240	0.264		
J(1)	2.41	2.92	0.095	0.115		
L	13.36	14.40	0.526	0.567		
L(1)	3.33	4.04	0.131	0.159		
ØР	3.53	3.94	0.139	0.155		
Q	2.54	3.00	0.100	0.118		
ECN: X15-0364-Rev. C, 14-Dec-15 DWG: 6031						

Note

 M* = 0.052 inches to 0.064 inches (dimension including protrusion), heatsink hole for HVM



Revison: 14-Dec-15 1 Document Number: 66542



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